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Single-Photon, Double Photodetachment of Nickel Phthalocyanine Tetrasulfonic Acid 4- Anions.

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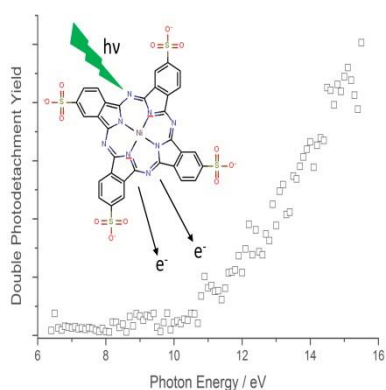
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Single-photon, two-electron photodetachment from nickel phthalocyanine tetrasulfonic acid tetra anions, NiPc^{4-} , was examined in the gas-phase using a linear ion trap coupled to the DESIRS VUV beamline of the SOLEIL Synchrotron. This system was chosen since it has a low detachment energy, known charge localization, and well defined geometrical and electronic structures. A threshold for two-electron loss is observed at 10.2 eV, around 1 eV lower than previously observed double detachment thresholds on multiple charged protein anions. The photodetachment energy of $[\text{NiPc}]^{4-}$ has been previously determined to be 3.5 eV and the photodetachment energy of $[\text{NiPc}]^{3-}$ is determined in this work to be 4.3 eV. The observed single photon double electron detachment threshold is hence 5.9 eV higher than the energy required for sequential single electron loss. Possible mechanisms are for double photodetachment are discussed. These observations pave the way toward new, exciting experiments for probing double photodetachment at relatively low energies, including correlation measurements on emitted photoelectrons.



The detachment of two electrons from a gas-phase species via the absorption of a single photon is a common process that is observed in systems as diverse as neutral or charged atoms, small molecules, molecular anions and multiply charged proteins (Table 1)¹⁻¹³. A range of mechanisms for double electron detachment are available, including processes such as Auger emission, shake-off processes, knock-out and relaxation following double excitation. In the case of multiply deprotonated proteins, the detachment of two electrons was found to be essentially independent of the charge state or size of the system, possessing an onset of ~11.2 eV across a diverse range of systems. However, due to the large size of proteins and a range of possible deprotonation sites, it is difficult to precisely identify the mechanism leading to

the single photon double electron detachment. It was, however, noted that 11.2 eV corresponds to the ionization energy of neutral tryptophan plus the electron affinity of the carboxylate (i.e. deprotonated carboxylic acid group), and that the onset of triple detachment required an additional 3.6 eV, which corresponds to the electron affinity of another carboxylate.

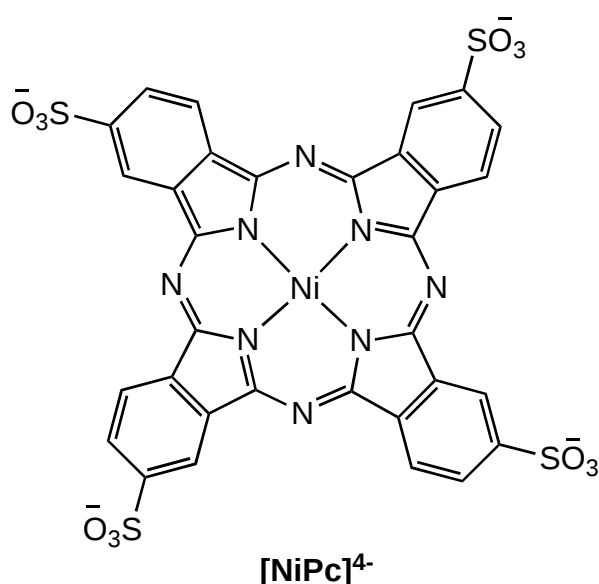
Table 1: Examples of one photon double electron loss processes described in the literature in which mass spectrometry (MS) is used to either select and/or detect ions.

Reactant species	Selected via MS?	Energy Range / eV	Detected via MS?	Examples	REF
M^{n+}	yes	>250	yes ^(a)	Multiply protonated proteins	[1]
M^+	yes	> 100	yes ^(a)	Clusters	[2]
M	no	> 17	yes	Atoms, small molecules, fullerenes	[3-7]
M^-	yes	>15	yes ^(b)	Li^- , F^- , CN^- , C_{60}^-	[8-10]
M^{2-}	yes	M	no ^(c)	Coinage metal clusters	[11]
M^{n-}	yes	> 11.4	yes	Multiply deprotonated proteins	[12,13]

(a) this channel requires a high energy photon (2 x ionization energy).

(b) this channel is called “charge reversal”.

(c) this channel is inferred from signal loss.



Scheme 1. The structure of the tetra-anion of Nickel Phthalocyanine tetrasulfonic acid.

Given that the folded structures and the location of the anionic sites in multiply deprotonated proteins are difficult to quantify, it is desirable to study a multiply charged anion (MCA) whose molecular architecture and electronic structure is well defined. The metal phthalocyanine tetrasulfonic acids (MPc) are amongst the smallest MCAs¹⁴⁻¹⁶ that meet these requirements and that can be transferred to the gas phase via electrospray ionization (ESI). As compared to previously studied MCAs, the excess electrons are localized on specific, spatially well-defined sites (see Scheme 1). Furthermore, spectroscopic data for photodetachment is already available; the gas-phase photoelectron spectroscopy of MPc MCAs has been studied by both the Wang^{17,18} and Kappes^{19,20} groups. It was found that the 4- charge states of CuPc and NiPc possessed a negative electron binding energy and were in fact metastable due to the presence of a Repulsive Coulomb Barrier (RCB). The MPc systems therefore represent the perfect candidates to study one photon two electron photodetachment at low energy. Here we use linear ion trap mass spectrometers coupled to either an OPO laser²¹ or a vacuum UV line of SOLEIL^{22,23} to explore the photodetachment of the 4- and 3-• charge states of NiPc (Scheme 1) with either UV or VUV light in an effort to characterize the one-photon two-electron photodetachment process.

The photochemistry of [NiPc]⁴⁻ is rich and involves both photofragmentation and photodetachment (see for example reference 24 and Figures S1-3 and Tables S1-2). The photodetachment yields of [NiPc]⁴⁻ in the VUV are shown in Figure 1(a) for 1 electron loss, while that for 2 electron loss is shown in Figure 1(b).

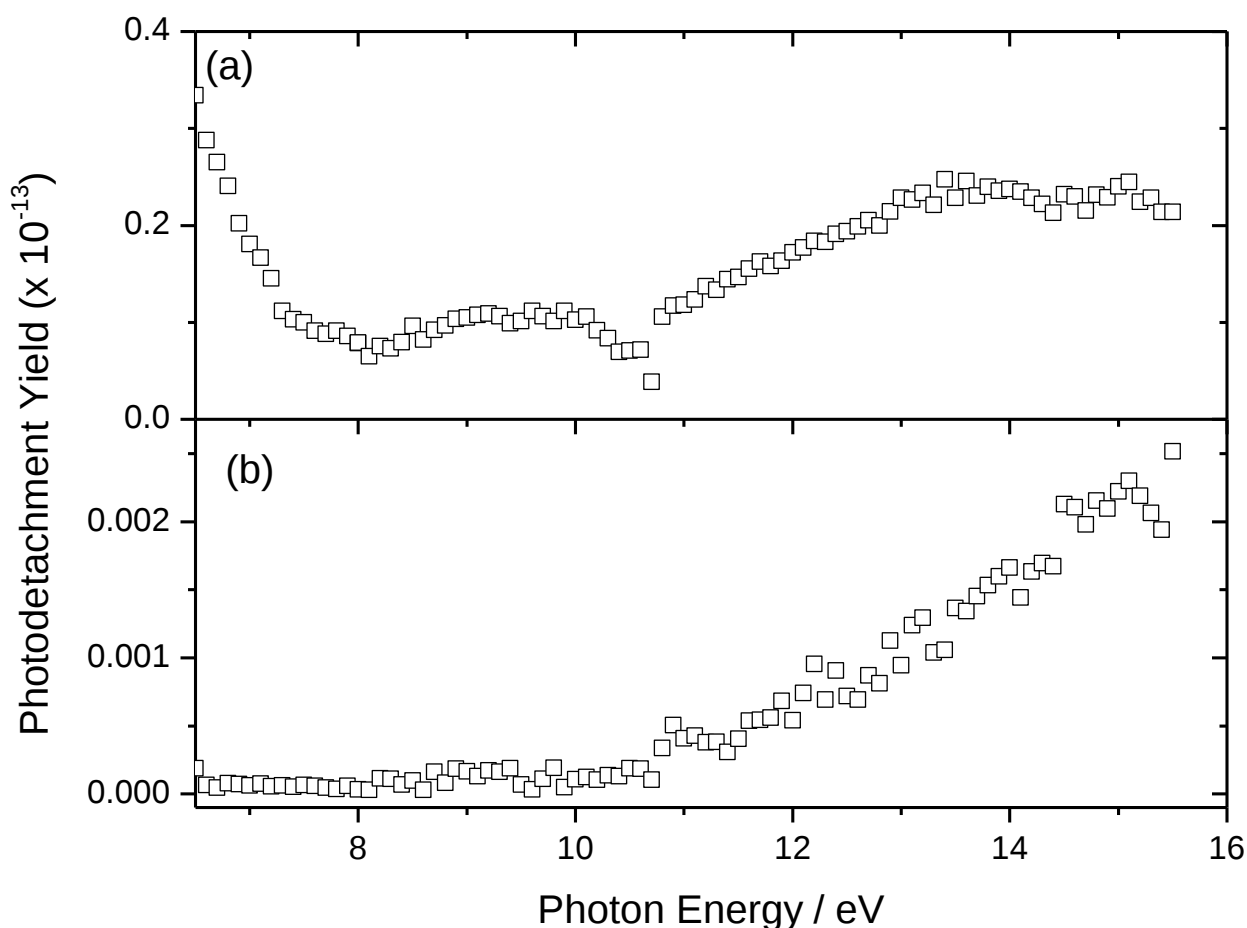


Figure 1. Photodetachment yields of $[\text{NiPc}]^{4-}$ in the VUV: (a) 1 electron loss and (b) 2 electron loss. An onset of 10.2 eV is observed in for the double electron loss process along with a feature in the single electron loss yield.

A similar trend in the photodetachment yields is observed, which increase at photon energies above 10 eV, with an onset observed at a photon energy of 10.2 eV for 2 electron loss (see Figure S4). Since thermal electron loss from the metastable $[\text{NiPc}]^{4-}$ anion is observed on the experimental timescale, fitting a threshold for 1 electron loss is not possible as it relies on a smooth baseline. Nevertheless, there is a clear feature in the photodetachment yield which appears to be concurrent with the onset observed in the two electron loss channel (see Figure S5).

In order to establish whether there is direct two electron loss or if sequential electron losses occurs via absorption of two individual photons, the dependence of the single and double photodetachment yields were monitored as a function of the irradiation time at 7, 9 and 15 eV

– Figure 2. For all photon energies it is clear that single photodetachment has a linear dependence on the irradiation time, indicating the expected single photon process. In the case of double electron loss, the dependence is clearly quadratic for 7 and 9 eV – both of which are below the onset of 10.2 eV – indicating a sequential two photon process. At 15 eV, the dependence of double detachment on irradiation – whilst still containing a trace of quadratic and hence two photon sequential detachment – is clearly much more linear than below the observed double detachment threshold and hence this threshold can be attributed to be predominantly a direct, single photon double electron detachment phenomenon (see Figure S6). A noteworthy difference is that the yield for 1 electron loss is around 2 orders of magnitude greater than 2 electron loss. Furthermore, the fact that the observed 1 and 2 electron loss channels share similar features in the VUV above 10 eV (Figure 1) may indicate that these two processes represent different relaxation pathways of the same initial excitation.

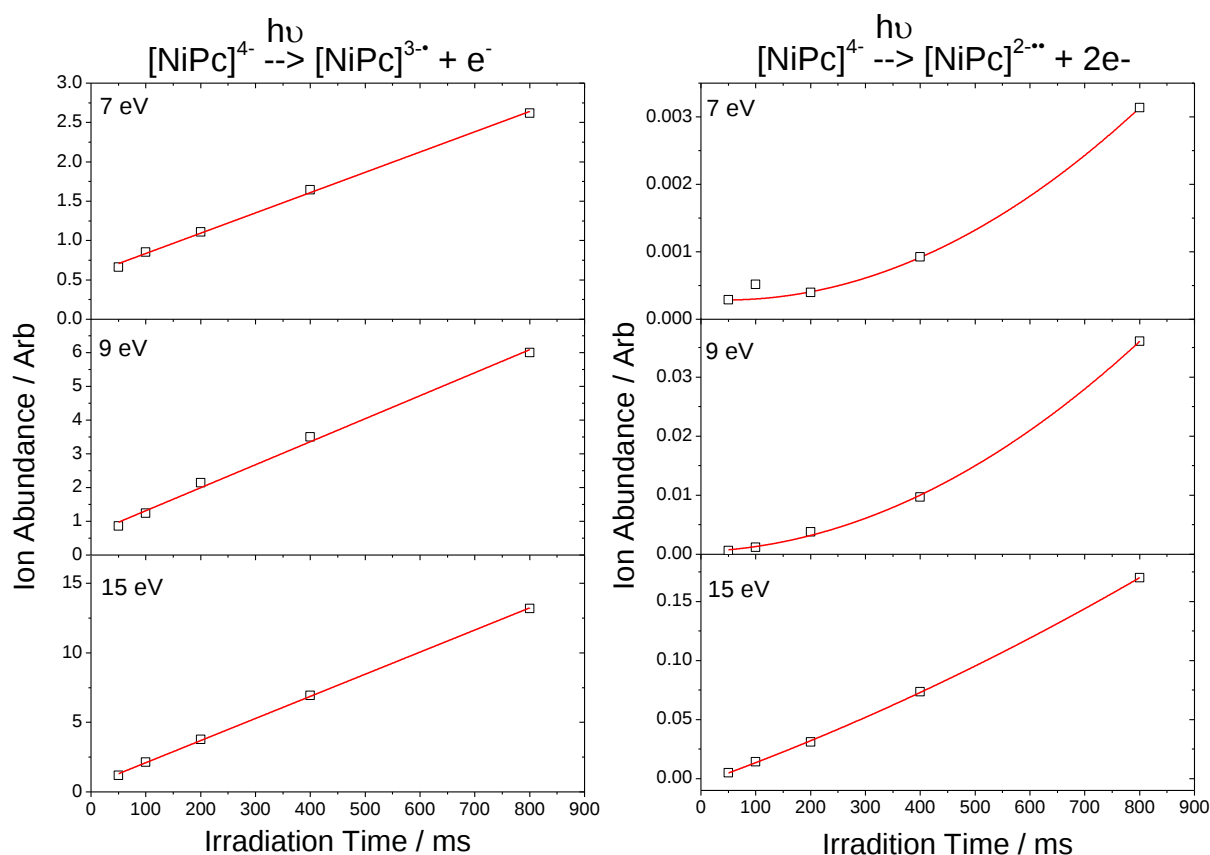


Figure 2. Single (left) and double (right) photodetachment yields as a function of the irradiation time at 7 eV (top), 9 eV (middle) and 15 eV (bottom).

The onset of 2 electron loss in $[\text{NiPc}]^{4-}$ is about 1 eV lower than previously observed double detachment thresholds of multiple charged protein anions^{13,25}, and as far as we are aware represents a new record for the lowest value for single photon, double detachment in the gas phase of any species. In the protein polyanion case, it was noted that there was a correlation with the ionization energy for the tryptophan side chain plus the detachment energy of the carboxylate anion, suggesting a possible mechanism in which 1 electron is removed from the tryptophan side chain and the other from the carboxylate, but without any footprint for how the two electrons are correlated. For $[\text{NiPc}]^{4-}$, the compact structure and well-defined charge location facilitates comprehension of how the emitted electrons may be correlated.

There are, in general, four possible mechanisms for the loss of two electrons following absorption of a single photon: (i) Auger-like processes whereby removal of a core electron causes emission of a second electron during relaxation; (ii) direct processes where double electron excitation leads directly to emission of two electrons; (iii) shake-off processes where the detachment of the first electron leaves the charge-reduced molecule in an excited state that can relax by emitting a second electron; and (iv) knockout processes where the kinetic energy of the outgoing photoelectron can be transferred to a second electron, causing it to be emitted as well.

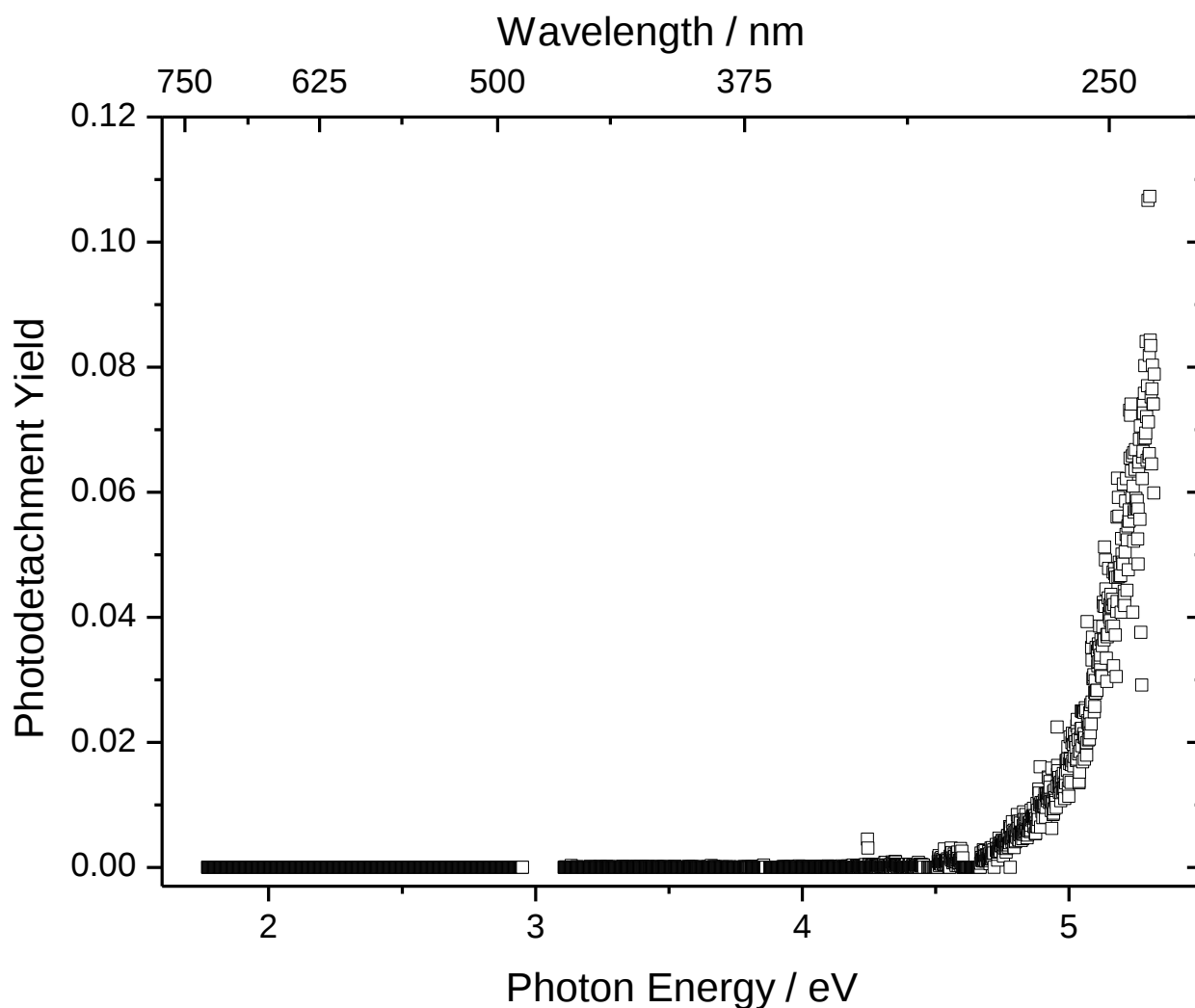


Figure 3. Photodetachment yield of $[\text{NiPc}]^{3\cdot-} \rightarrow [\text{NiPc}]^{2\cdot-} + e^-$ in the range 1.78 to 5.5 eV.

To better quantify the lower limits for the energetics associated with 2 electron loss from $[\text{NiPc}]^{4-}$, it is important to know the energy for sequential single electron loss. The photoelectron spectroscopy for single electron loss from $[\text{NiPc}]^{4-}$ has been reported²⁶. Although $[\text{NiPc}]^{3\cdot-}$ has a negative electron affinity (-0.65 eV), there is a RCB, which costs 3.5 eV to be surmounted. The missing piece of information is the energy required to remove an electron from $[\text{NiPc}]^{3\cdot-}$. Thus we have measured the photodetachment spectrum of $[\text{NiPc}]^{3\cdot-}$ between 1.8 and 5.5 eV (Figure 3), with an onset of 4.3 eV observed (see Figure S7). This value may be used in conjunction with the height of the RCB of $[\text{NiPc}]^{4-}$ to construct a diagram for the energetics of photodetachment (Figure 4). Although the relative energy of

$[\text{NiPc}]^{2-\bullet}$ is not known, it is not relevant to the discussion of double electron loss from $[\text{NiPc}]^{4-}$ and an arbitrary value is assumed in Figure 4.

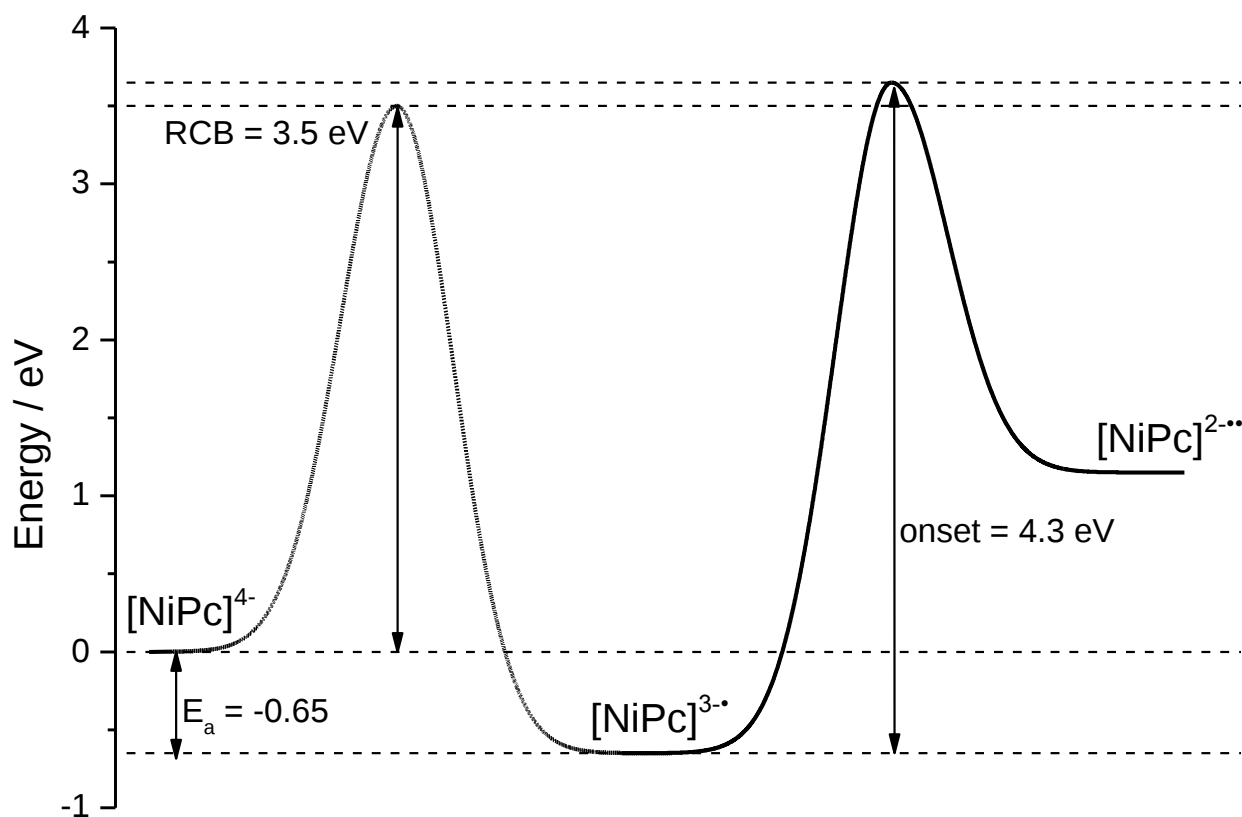


Figure 4. Schematic diagram showing the relative energetics for removal of an electron from either $[\text{NiPc}]^{4-}$ or $[\text{NiPc}]^{3-\bullet}$. The RCB for $[\text{NiPc}]^{4-}$ and the relative energy of $[\text{NiPc}]^{4-}$ and $[\text{NiPc}]^{3-\bullet}$ are taken from references^{19,20}. The value for $[\text{NiPc}]^{3-\bullet}$ is taken from the electron detachment onset of this species shown in Figure 3.

The threshold for sequential two photon detachment is 4.3 eV, corresponding to the onset of photodetachment of $[\text{NiPc}]^{3-\bullet}$, the largest barrier which must be surmounted (absorption of 2 photons of 4.3 eV; $[\text{NiPc}]^{4-} \rightarrow [\text{NiPc}]^{3-\bullet} \rightarrow [\text{NiPc}]^{2-\bullet}$). This process has already been eliminated by the linearity of double photodetachment in Figure 2. Auger-type relaxation channels are typically not open in the VUV region, with photon energies of at least 25 eV generally being required⁸ and thus may be discounted as the mechanism responsible for 2 electron detachment here. In the knock-out process, the electron kinetic energy of the photoelectron is responsible for removal of the second electron. Hence, the threshold energy for this channel is the sum of the binding energies of the two electrons removed. In the case of

$[\text{NiPc}]^{4-}$ the situation is complicated by the negative binding energy relative to the $[\text{NiPc}]^{3\cdot-}$ and the RCB. A photoelectron emitted after absorption of a photon of 3.5 eV (i.e. just above the RCB) will have a maximum kinetic energy of 4.15 eV due to the -0.65 eV binding energy. Since the onset for photodetachment of $[\text{NiPc}]^{3\cdot-}$ is 4.3 eV, a 3.65 eV photon is all that is required for the photoelectron emitted from $[\text{NiPc}]^{4-}$ to have sufficient kinetic energy to remove an electron from $[\text{NiPc}]^{3\cdot-}$. This is 6.55 eV lower than the observed threshold, which would appear to exclude this mechanism of two electron detachment. It has been previously shown that the first electron removed from $[\text{NiPc}]^{4-}$ comes from the π system of the phthalocyanine²⁴. Given that this electron is corralled by the sulfonates, the electron will preferentially leave the system in the out-of-plane directions. Such an asymmetry in the angle of photoemission would minimize the potential interaction with other electrons in the system, and in particular with the electrons in the negatively charge sulfonate group. It is thus reasonable to exclude knock-out type mechanisms as the origin of two electron loss in $[\text{NiPc}]^{4-}$.

This, therefore, leaves the direct double detachment and shake-off processes as possible mechanisms. Both are consistent with the observed onsets of 1 and 2 electron detachment, and both are non-resonant processes based upon electron correlation. There is evidence for relatively intense double photoionization processes in aromatic hydrocarbons with He-like energy trends and depending in magnitude of the molecules²⁷. Shake-off ionization can be described as a sudden change in the potential after ionization of the first electron, who can relax by ejection of a second electron.³⁰ This has likewise been shown to be important in small molecules, and may dominate at threshold where knock-out processes are absent (as they appear to be here)^{28,29}. Considering the very low electron binding energy in polyanions, as compared to neutrals, shake-off processes may be expected to be quite efficient. Although there is evidence of electron correlation in the observation of linked single and double

electron detachment channel yields, there is no information on the relative energetics of the two electrons, or the timescale of their emission. In particular for a correlated double electronic excitation leading to concerted double photoemission, electrons with the similar kinetic energy are expected whilst for shake-off two different kinetic energy photoelectrons may be expected. Disentangling these two channels would require use of a photoelectron-photoelectron coincidence (PEPECO) experiment in order to measure the photoelectron kinetic energies and especially the energy sharing between the two outgoing electrons as it is regularly performed on neutrals^{4,31}. To our knowledge such a PEPECO scheme has never been applied to trapped ions.

In summary, the single and double electron detachment from $[\text{NiPc}]^{4-}$ has been studied using a combination of laser- and synchrotron-based spectroscopy in a linear ion trap. An onset of 10.2 eV was found for double electron detachment, which is the lowest currently observed threshold for one-photon double detachment. The measurement of the double detachment yield as function of the irradiation time showed a predominately linear trend above this threshold, which eliminates sequential photon absorption as a mechanism. In order to quantify the energetics of sequential electron detachment after absorption of two photons, the photodetachment of $[\text{NiPc}]^{3-\bullet}$ was measured between 1.8 and 5.5 eV, with an onset of 4.3 eV observed. The well-defined geometry of the molecule has allowed a detailed spectroscopic characterization to be performed, allowing an evaluation of potential mechanisms for one-photon two-electron loss from a consideration of all relevant energetics. Auger- and knock-out processes were discounted, suggesting that direct detachment following double excitation is the most likely mechanism leading to double photodetachment. This argument is strengthened by similarities of the VUV features for single and double electron detachment yields above 10 eV (Figure 1). Observation of one-photon two-electron emission at 10.2 eV opens up the prospect of studying high energy ionization processes at rather low excitation

energies (in the VUV), where detailed spectroscopic and theoretical studies are more easily done. In particular, instrumentation recently developed for photo product anion – photo-electron coincidence spectroscopy could provide important information on the energy electrons formed in single photon double electron detachment,^{32–34} although genuine PEPECO experiment would also be highly desirable.^{4,31}

Supporting Information. Experimental details, mass spectra with assignments, fitted photodetachment spectra and linear vs quadratic component of irradiation time plots can be found in the supporting information (PDF). These files are available free of charge.

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Supplementary Material

Single-Photon, Double Photodetachment of Nickel Phthalocyanine Tetrasulfonic Acid 4- Anions.

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Experimental Methods

Materials: Chemicals from the following suppliers were used without further purification: (i) nickel phthalocyanine tetrasulfonic acid tetrasodium salt, NiPc, was purchased from Sigma-Aldrich (Saint Quentin Fallavier, France); (ii) methanol was HPLC grade sourced from Fisher Chemical (Fisher Scientific, UK); (iii) Milli-Q water (18.2 M Ω .cm; Millipore Corporation Billerica, MA, USA) was used.

Mass spectrometry:

Water solutions of NiPc (0.8 mg/mL) were further diluted with methanol:water 50:50 (% v/v) to a concentration of around 40 μ M and introduced into modified quadrupole linear ion trap mass spectrometers (LTQ, Thermo Fisher Scientific, San Jose, CA, USA) via electrospray ionization (ESI) using a syringe pump set to a flow rate of 5 μ L.min⁻¹. The typical ESI conditions used were: spray voltage, -5.0 kV, capillary temperature, 150°C, nitrogen sheath gas pressure, 10 (arbitrary units), capillary voltage -2 V. NiPc^{3••} were formed via collision induced electron detachment from mass selected NiPc⁴⁺ for an activation time of 30 ms with a normalized collision energy set to 15 %. The mass selected NiPc⁴⁺ and NiPc^{3••} were subjected to irradiation in two different modified mass spectrometers, discussed separately below.

Spectroscopy over range of 6 to 16 eV:

VUV experiments were carried out on a Thermo LTQ linear ion trap mass spectrometer that has been coupled to the undulator based DESIRS beamline of the SOLEIL synchrotron^{1,2}. Two different methods were employed to ensure the suppression of higher harmonics of the undulator. Between 5 – 8 eV a MgF window was inserted just before the ion trap; for photon energies higher than 8 eV, a gas filter³ filled with 0.25 mbar argon was used. A 5.57 m normal incidence monochromator with a 200 gr/mm grating was used, providing a bandwidth of approximately 30 meV at 12 eV and a photon flux of the order 10¹³ photons per second. For all photon energies the entrance and exit slits to the monochromator were set to 200 and 400 μ m respectively. The action spectrum was performed in two scans defined by the regimes for

suppression of the higher order light given above. In the 5 – 8 eV region, an irradiation time of 200 ms and acquisition time of 4 minutes per wavelength were used for both 4- and 3- σ . In the 8 – 16 eV region the irradiation time was reduced to 150 ms due to the greater photon flux from the undulator and increased cross-section and the acquisition time reduced to 90 seconds per photon energy.

Spectroscopy over range of 1.8 to 5.5 eV:

The experimental setup used to perform the experiments presented in this paper has been described in detail previously⁴. Briefly, a linear quadrupole ion trap mass spectrometer (LTQ Velos, Thermo Fisher Scientific, San Jose, CA) was used to generate, mass select, and trap ions in a first, high pressure trap for a controlled period during which time they may be activated by laser irradiation (LID). Fragment ions are subsequently transmitted to a second, lower pressure ion trap, and are mass analyzed. A fused silica window (3 mm thick, 1 in. diameter) is positioned at the back end of the instrument, and 1-2 mm diameter circular openings in the trapping electrodes allow coupling of light source and trapped ions. In order to optimize laser transmission, the central hole of the electrode closest to the fused silica window was enlarged to 5 mm in diameter.

The light source used was a Horizon OPO pumped by the third harmonic of a Surelite II Nd:YAG laser (Continuum, Santa Clara, CA). A repetition rate of 10 Hz and a pulse width of 5 ns were used. The beam was focused into the first ion trap using a 1,000 mm focal length convergent lens. A mechanical shutter, synchronized with the mass spectrometer, was used to stop the beam at all times except the “ion activation window”, that is, the time after ion accumulation and before the mass analysis. A single laser pulse was used for the irradiation of the trapped ions, and when irradiating ions the normalized collision energy is kept at zero.

To record action spectra, the laser wavelength was scanned between 700 and 420 nm, and between 399 and 235 nm, in 0.03 nm steps and with a 1 s dwell time at each wavelength.

Mass spectra were recorded every 9 μ scans, which corresponded on average to one mass spectrum per second. Laser power was recorded by performing a second scan under identical conditions immediately following acquisition of the action spectrum.

Data analysis:

To analyze the UV-Vis data, each mass spectrum was assigned a wavelength value given by

$$\lambda_{start} - \left((i - 1) * \left(\frac{\Delta\lambda}{n} \right) \right)$$

where λ_{start} is the starting wavelength of the scan, i the mass spectrum number, $\Delta\lambda$ is the total wavelength change during the scan, and n the total number of mass spectra acquired during the acquisition. The same procedure was used to provide a wavelength range for the laser power (P), and a linear interpolation performed to give values of the laser power at the wavelengths assigned to each mass spectrum. For the VUV data, a fixed photon energy is used for each mass spectrum, so the wavelength is explicitly known. A flux-normalized yield of photo-detachment is deduced from the mass spectrum through:

$$(I_{PD}/I_{total})/\phi$$

Where I_{PD} is the intensity of the photodetached species, I_{total} is the total intensity, and ϕ is the photon flux which is directly measured by a photodiode in the VUV and is given by $\lambda * P$ where P is the laser power in the UV-Vis. Double photo-detachment yield is deduced from the mass spectrum through:

$$(I_{2PD}/I_{total})/\phi$$

Where I_{2PD} is the intensity of the double photodetached species.

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- (2) Milosavljević, A. R.; Nicolas, C.; Gil, J.-F.; Canon, F.; Réfrégiers, M.; Nahon, L.; Giuliani, A. VUV Synchrotron Radiation: A New Activation Technique for Tandem Mass Spectrometry. *J. Synchrotron Radiat.* **2012**, *19*, 174–178.
- (3) Mercier, B.; Compin, M.; Prevost, C.; Bellec, G.; Thissen, R.; Dutuit, O.; Nahon, L. Experimental and Theoretical Study of a Differentially Pumped Absorption Gas Cell Used as a Low Energy-Pass Filter in the Vacuum Ultraviolet Photon Energy Range. *J. Vac. Sci. Technol. a-Vacuum Surfaces Film.* **2000**, *18*, 2533–2541.
- (4) Daly, S.; Kulesza, A.; Knight, G.; MacAleese, L.; Antoine, R.; Dugourd, P. Visible and Ultraviolet Spectroscopy of Gas Phase Rhodamine 575 Cations. *J. Phys. Chem. A* **2015**, *119*, 5634–5641.

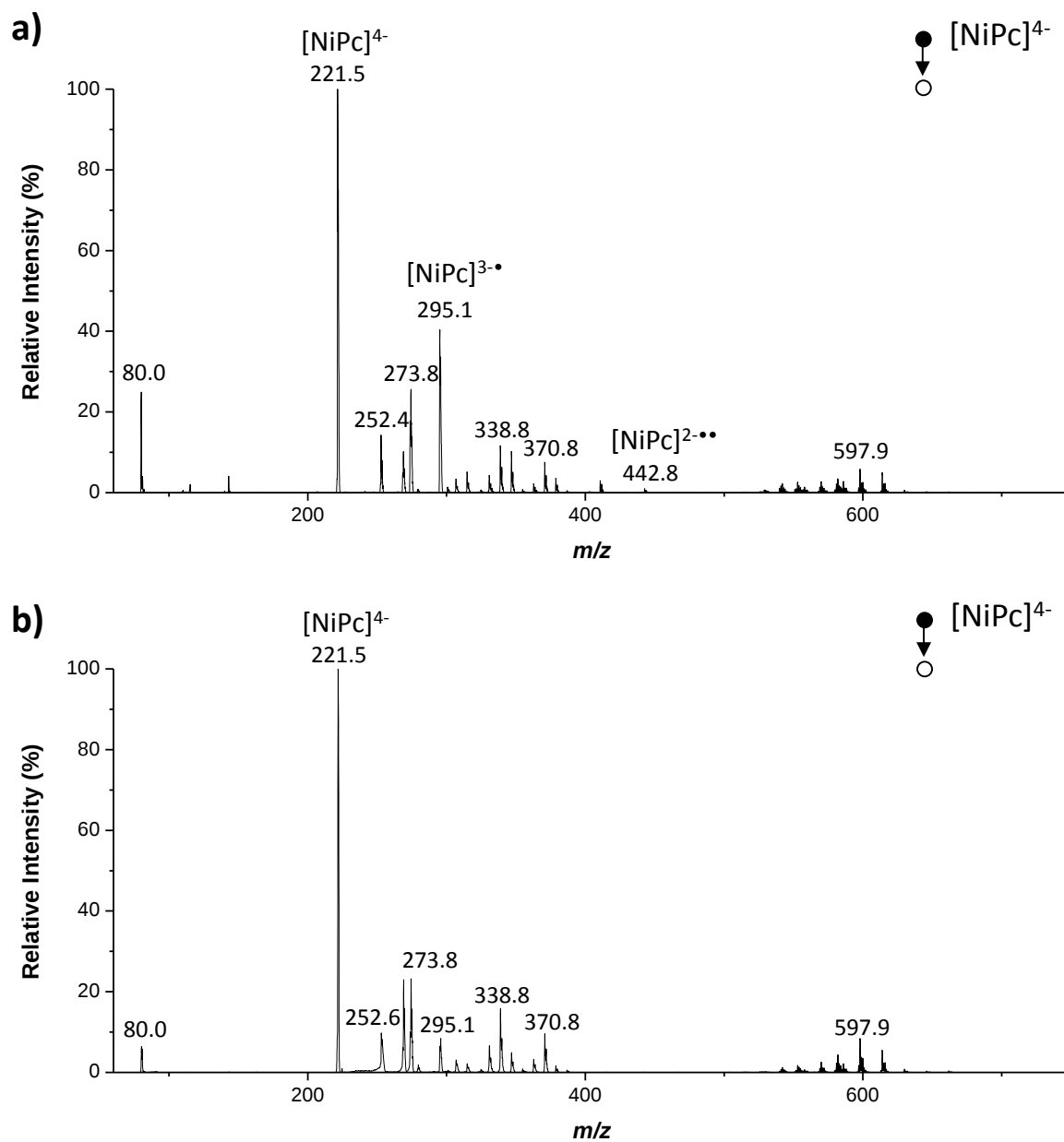


Figure S1. LID spectrum of $[NiPc]^{4-}$ ion (m/z 221.5) at a) 5.28 eV and b) 1.88 eV. Activation time 100 ms.

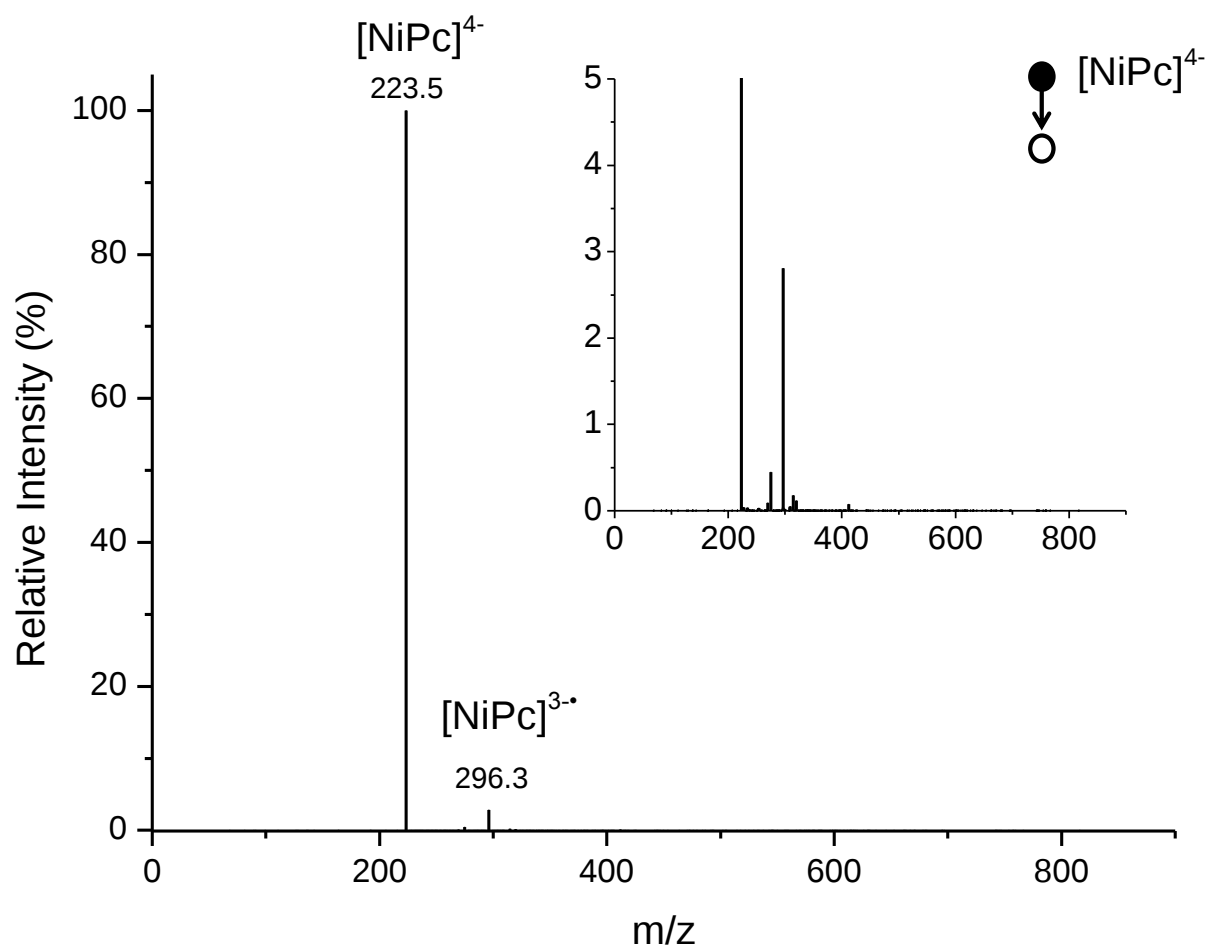


Figure S2. LID spectrum of $[\text{NiPc}]^{4-}$ ion (m/z 223.5) at a) 15 eV. Activation time 150 ms.

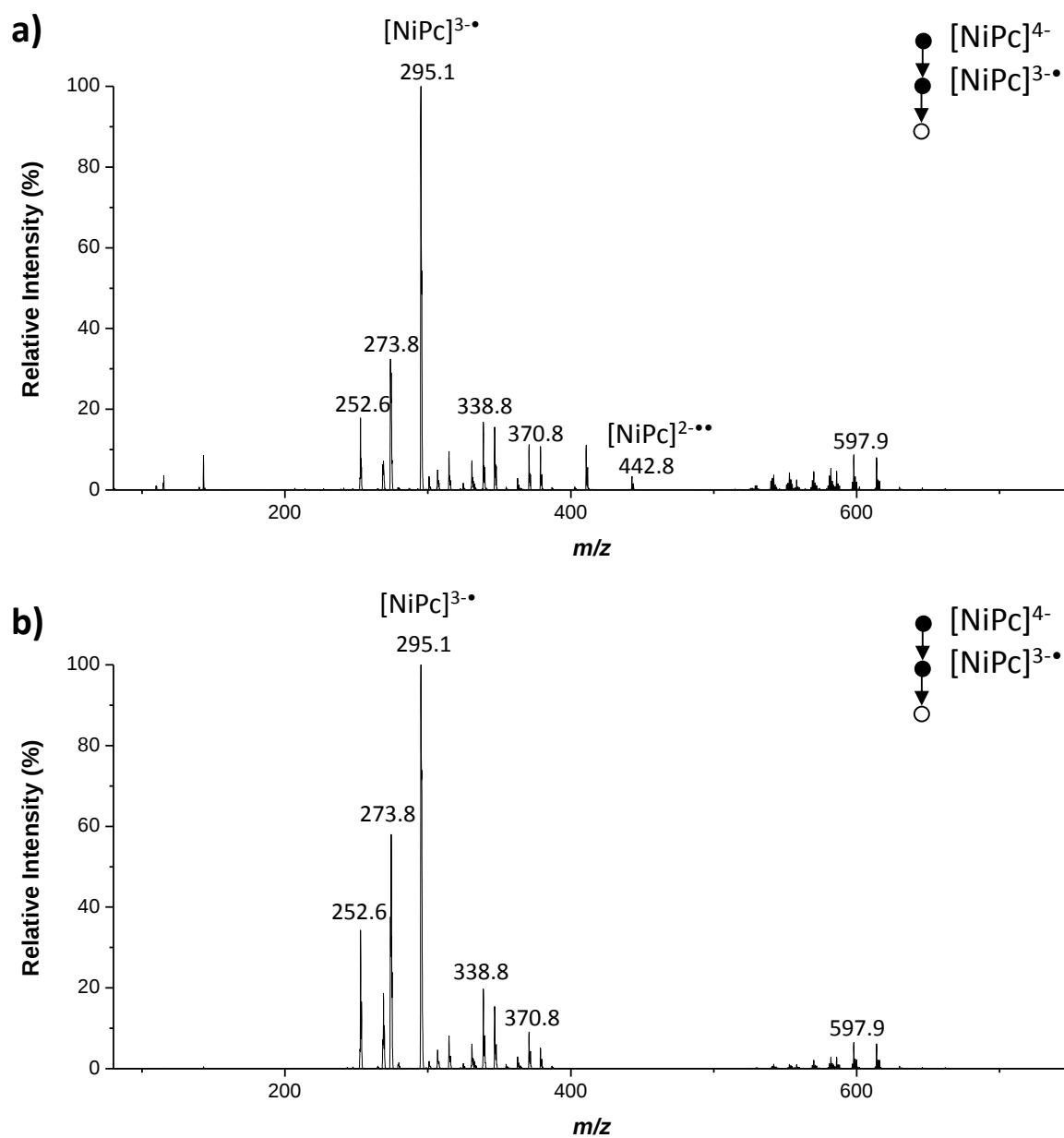


Figure S3. LID spectrum of $[\text{NiPc}]^{3-\bullet}$ ion (m/z 295.1) at a) 5.28 eV and b) 1.88 eV. Activation time 100 ms.

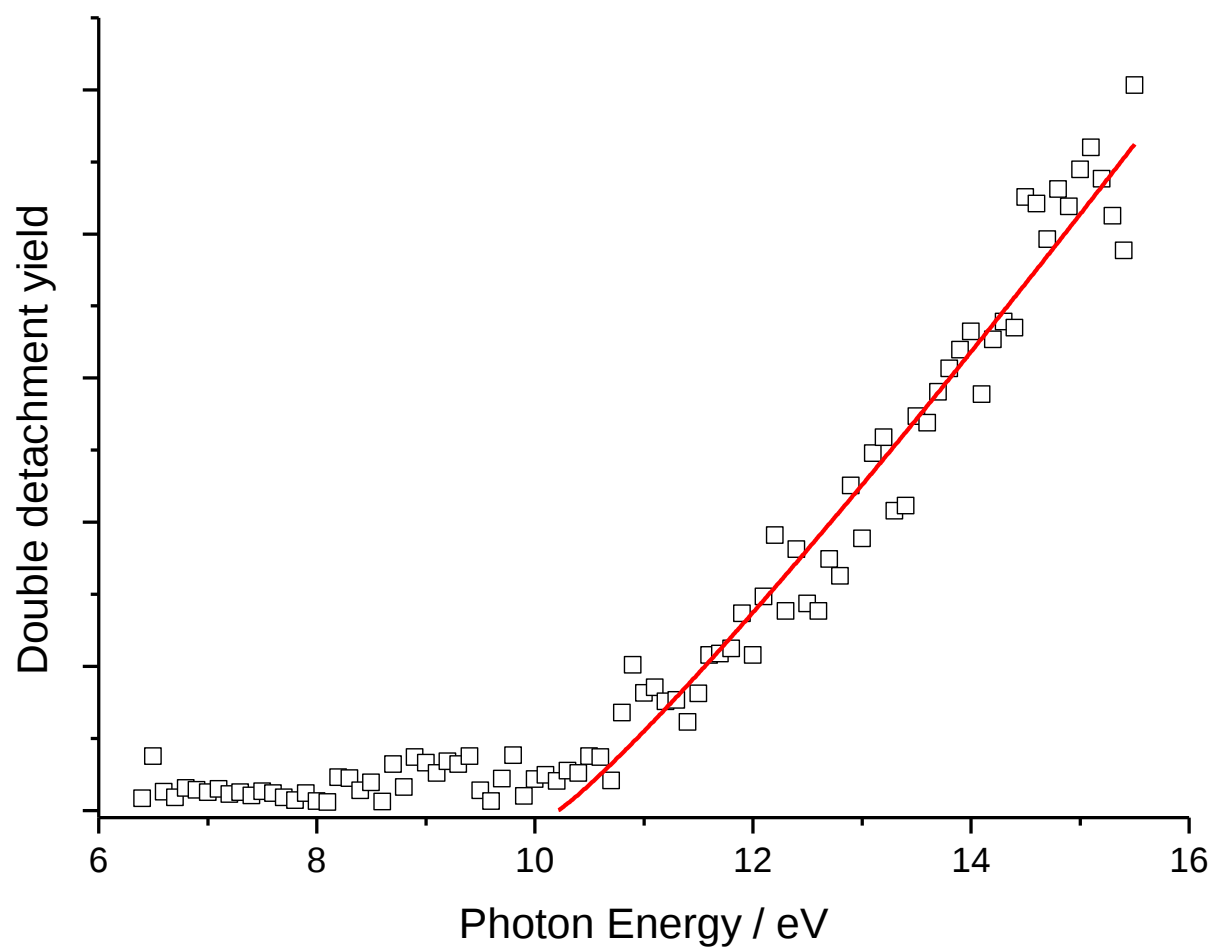


Figure S4. Wannier-type fit to the onset of double photodetachment of $[\text{NiPc}]^{4-}$.

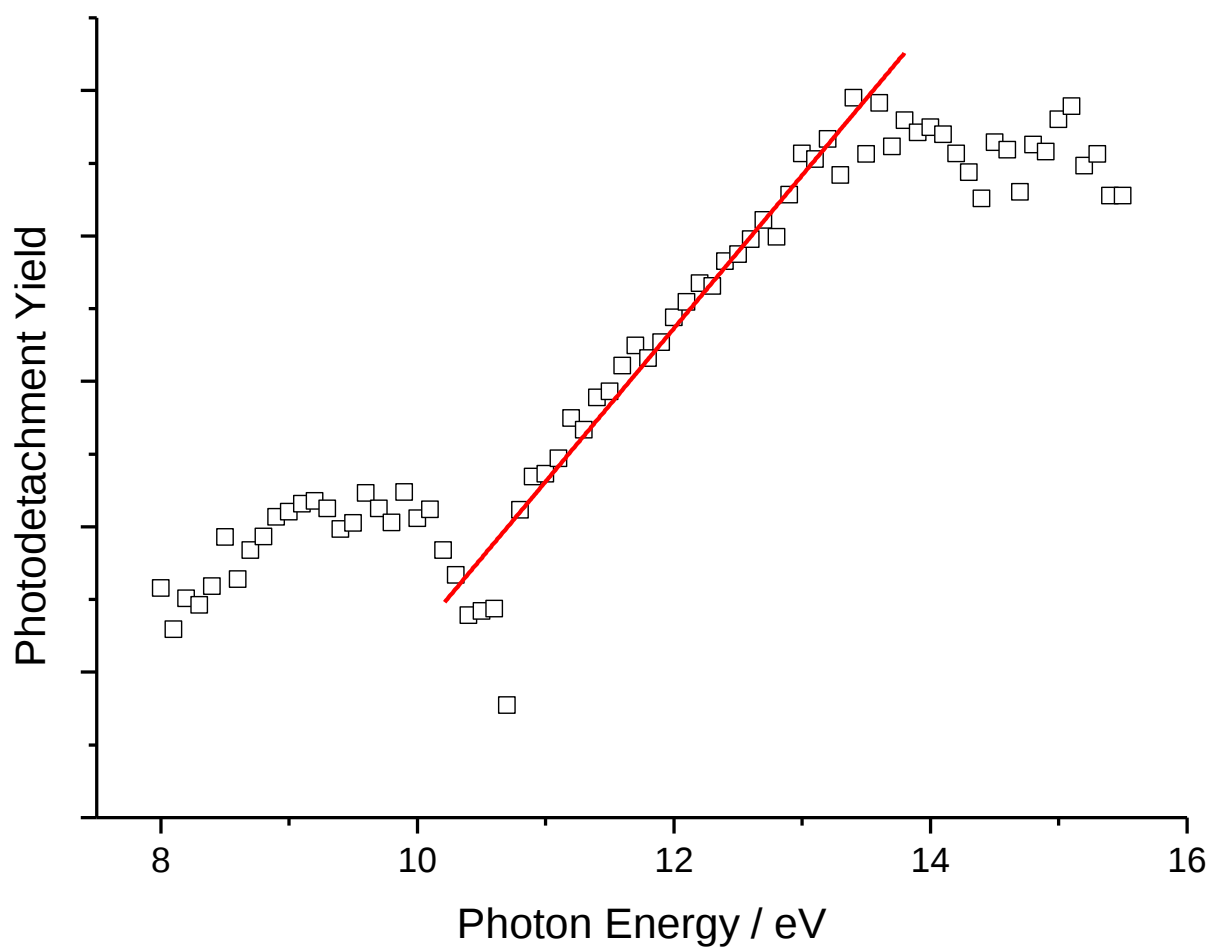


Figure S5. Linear fit for the VUV onset of photodetachment of $[\text{NiPc}]^{4+}$ to the baseline. Since thermal electron loss is observed from $[\text{NiPc}]^{4+}$ - which is metastable – there is a raised and relatively noisy baseline. This precludes the use of the Wannier-type onset fit which is used in Figures S4 and S7.

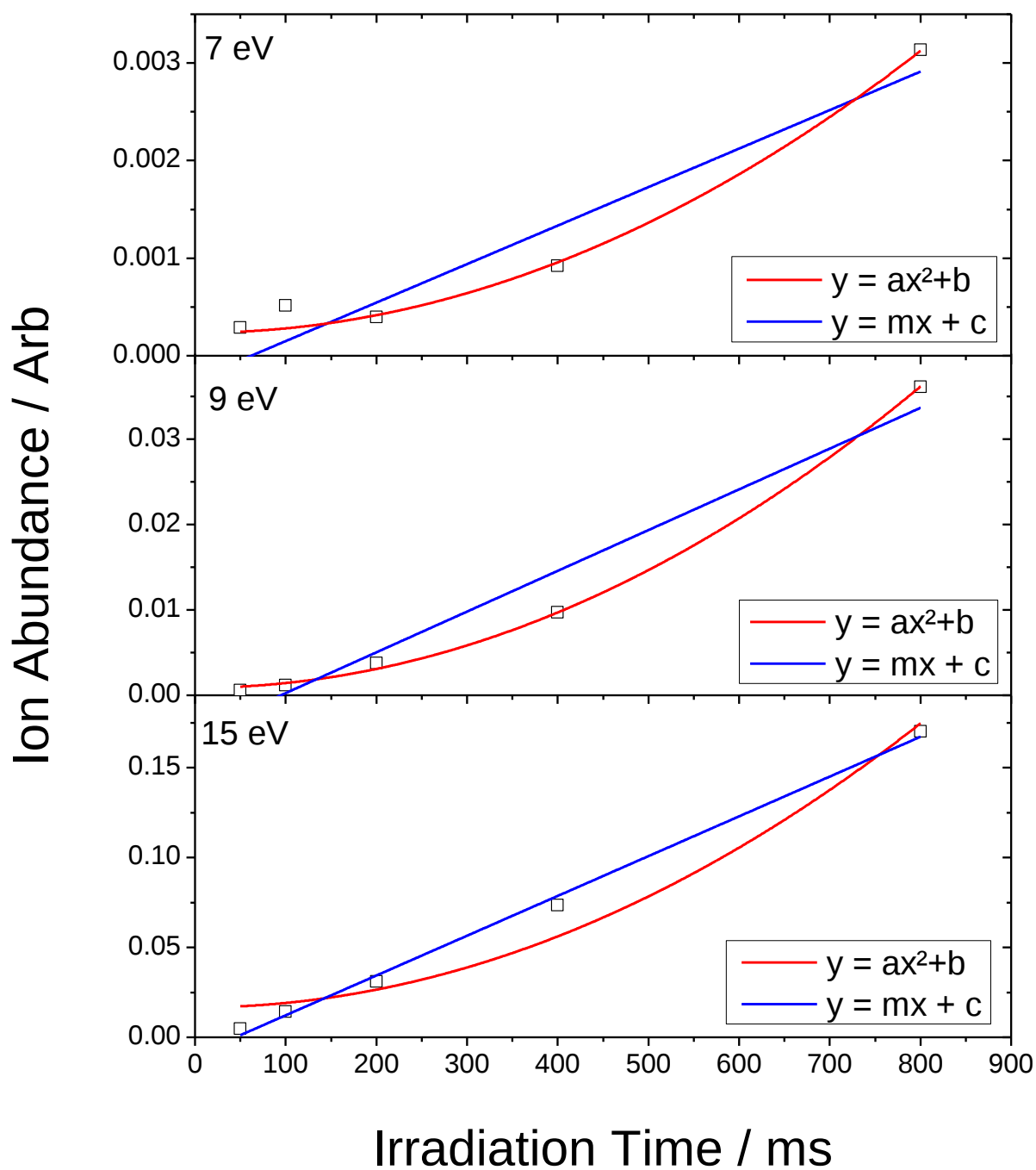


Figure S6. Fitting of the ion abundance as a function of irradiation time using either purely linear (blue) or purely quadratic (red) functions. At 7 and 9 eV the ion abundance clearly has a quadratic dependence on the irradiation time, whilst at 15 eV linear is clearly dominant (although a quadratic component is still present).

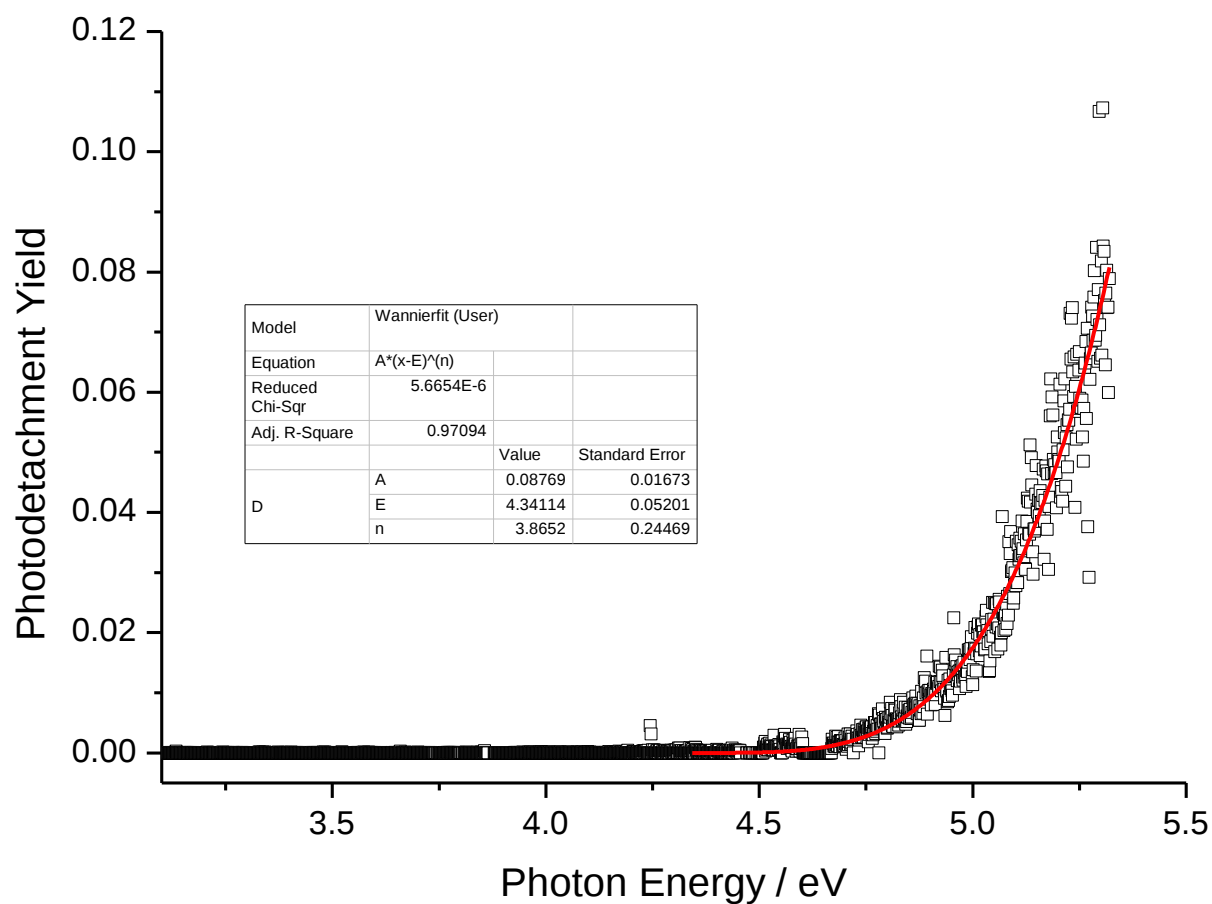


Figure S7. Wannier-type fit to the onset of photodetachment of $[\text{NiPc}]^{3-\bullet}$.

Table S1. Summary of product ions observed upon irradiation of $[\text{NiPc}]^{4-}$ ion at m/z 221.5.

<i>m/z</i>	Assignment	Losses
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80.0	$\text{SO}_3^{\cdot-}$	$[\text{NiPc-SO}_3]^{3\cdot-}$
110.3	$[\text{Ni}+2\text{SO}_3+\text{SO}_2+\text{SOH}]^{3-}$	
115.3	$[\text{Ni}+2\text{SO}_3+2\text{SO}_2]^{3\cdot-}$	
143.0	$[\text{C}_6\text{H}_5+\text{SO}_2\text{H}_2]^-$	
221.5	$[\text{NiPc}]^{4-}$	
252.4	$[\text{NiPc-2SO}_2]^{3\cdot-}$	1 e- and 2 SO_2
268.6	$[\text{NiPc-SO}_3]^{3\cdot-}$	1 e- and SO_3
273.8	$[\text{NiPc-SO}_2]^{3\cdot-}$	1 e- and SO_2
295.1	$[\text{NiPc}]^{3\cdot-}$	1 e-
298.8	$[\text{NiPc-2SO}_2\text{-2SO}_3]^{2\cdot-}$	2 e- ; 2 SO_2 and 2 SO_3
306.8	$[\text{NiPc-3SO}_2\text{-SO}_3]^{2\cdot-}$	2 e- ; 3 SO_2 and SO_3
314.8	$[\text{NiPc-4SO}_2]^{2\cdot-}$	2 e- and 4 SO_2
322.8	$[\text{NiPc-3SO}_3]^{2\cdot-}$	2 e- and 3 SO_3
330.8	$[\text{NiPc-SO}_2\text{-2SO}_3]^{2\cdot-}$	2 e- ; SO_2 and 2 SO_3
338.8	$[\text{NiPc-2SO}_2\text{-SO}_3]^{2\cdot-}$	2 e- ; 2 SO_2 and SO_3
346.8	$[\text{NiPc-3SO}_2]^{2\cdot-}$	2 e- and 3 SO_2
354.8	$[\text{NiPc-2SO}_2\text{-SO}]^{2\cdot-}$	2 e- ; 2 SO_2 and SO
362.8	$[\text{NiPc-2SO}_3]^{2\cdot-}$	2 e- and 2 SO_3
370.8	$[\text{NiPc-SO}_2\text{-SO}_3]^{2\cdot-}$	2 e- ; SO_2 and SO_3
378.8	$[\text{NiPc-2SO}_2]^{2\cdot-}$	2 e- and 2 SO_2
386.8	$[\text{NiPc-SO}_2\text{-SO}]^{2\cdot-}$	2 e- ; SO_2 and SO
402.8	$[\text{NiPc-SO}_3]^{2\cdot-}$	2 e- and SO_3
410.8	$[\text{NiPc-SO}_2]^{2\cdot-}$	2 e- and SO_2
442.8	$[\text{NiPc}]^{2\cdot-}$	2 e-
565.9	$[\text{NiPc-4SO}_3]^{1\cdot-}$	3 e- and 4 SO_3
581.9	$[\text{NiPc-SO}_2\text{-3SO}_3]^{1\cdot-}$	3 e- ; SO_2 and 3 SO_3
597.9	$[\text{NiPc-2SO}_2\text{-2SO}_3]^{1\cdot-}$	3 e- ; 2 SO_2 and 2 SO_3
613.9	$[\text{NiPc-3SO}_2\text{-SO}_3]^{1\cdot-}$	3 e- ; 3 SO_2 and SO_3
629.9	$[\text{NiPc-4SO}_2]^{1\cdot-}$	3 e- and 4 SO_2
645.9	$[\text{NiPc-3SO}_2\text{-SO}]^{1\cdot-}$	3 e- ; 3 SO_2 and SO
661.9	$[\text{NiPc-3SO}_3]^{1\cdot-}$	3 e- and 3 SO_3

Table S2. Summary of product ions observed upon irradiation of $[\text{NiPc}]^{3-\bullet}$ ion at m/z 295.1.

<i>m/z</i>	Assignment	Losses
110.3	$[\text{Ni}+2\text{SO}_3+\text{SO}_2+\text{SOH}]^{3-}$	
115.3	$[\text{Ni}+2\text{SO}_3+2\text{SO}_2]^{3-\bullet}$	
143.0	$[\text{C}_6\text{H}_5+\text{SO}_2\text{H}_2]^-$	
252.6	$[\text{NiPc}-2\text{SO}_2]^{3-\bullet}$	2 SO_2
268.6	$[\text{NiPc}-\text{SO}_3]^{3-\bullet}$	SO_3
273.8	$[\text{NiPc}-\text{SO}_2]^{3-\bullet}$	SO_2
295.1	$[\text{NiPc}]^{3-\bullet}$	
298.8	$[\text{NiPc}-2\text{SO}_2-2\text{SO}_3]^{2-\bullet\bullet}$	1 e- ; 2 SO_2 and 2 SO_3
306.8	$[\text{NiPc}-3\text{SO}_2-\text{SO}_3]^{2-\bullet\bullet}$	1 e- ; 3 SO_2 and SO_3
314.8	$[\text{NiPc}-4\text{SO}_2]^{2-\bullet\bullet}$	1 e- and 4 SO_2
322.8	$[\text{NiPc}-3\text{SO}_3]^{2-\bullet\bullet}$	1 e- and 3 SO_3
330.8	$[\text{NiPc}-\text{SO}_2-2\text{SO}_3]^{2-\bullet\bullet}$	1 e- ; SO_2 and 2 SO_3
338.8	$[\text{NiPc}-2\text{SO}_2-\text{SO}_3]^{2-\bullet\bullet}$	1 e- ; 2 SO_2 and SO_3
346.8	$[\text{NiPc}-3\text{SO}_2]^{2-\bullet\bullet}$	1 e- and 3 SO_2
354.8	$[\text{NiPc}-2\text{SO}_2-\text{SO}]^{2-\bullet\bullet}$	1 e- ; 2 SO_2 and SO
362.8	$[\text{NiPc}-2\text{SO}_3]^{2-\bullet\bullet}$	1 e- and 2 SO_3
370.8	$[\text{NiPc}-\text{SO}_2-\text{SO}_3]^{2-\bullet\bullet}$	1 e- ; SO_2 and SO_3
378.8	$[\text{NiPc}-2\text{SO}_2]^{2-\bullet\bullet}$	1 e- and 2 SO_2
386.8	$[\text{NiPc}-\text{SO}_2-\text{SO}]^{2-\bullet\bullet}$	1 e- ; SO_2 and SO

402.8	$[\text{NiPc-SO}_3]^{2-\bullet\bullet}$	1 e- and SO_3
410.8	$[\text{NiPc-SO}_2]^{2-\bullet\bullet}$	1 e- and SO_2
442.8	$[\text{NiPc}]^{2-\bullet\bullet}$	1 e-
565.9	$[\text{NiPc-4SO}_3]^{1-\bullet\bullet\bullet}$	2 e- and 4 SO_3
581.9	$[\text{NiPc-SO}_2\text{-3SO}_3]^{1-\bullet\bullet\bullet}$	2 e- ; SO_2 and 3 SO_3
597.9	$[\text{NiPc-2SO}_2\text{-2SO}_3]^{1-\bullet\bullet\bullet}$	2 e- ; 2 SO_2 and 2 SO_3
613.9	$[\text{NiPc-3SO}_2\text{-SO}_3]^{1-\bullet\bullet\bullet}$	2 e- ; 3 SO_2 and SO_3
629.9	$[\text{NiPc-4SO}_2]^{1-\bullet\bullet\bullet}$	2 e- and 4 SO_2
645.9	$[\text{NiPc-3SO}_2\text{-SO}]^{1-\bullet\bullet\bullet}$	2 e- ; 3 SO_2 and SO
661.9	$[\text{NiPc-3SO}_3]^{1-\bullet\bullet\bullet}$	2 e- and 3 SO_3